

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Report No: CCISE170700801

FCC REPORT

(GSM)

Applicant: SHENZHEN COOTEL FONE TECHNOLOGY CO., LTD

No.311, 3rd Floor, Langfeng Building, No.2, Kefa Road, Central

Address of Applicant: Area of Science and Technology Park, Nanshan District,

Shenzhen, China

Equipment Under Test (EUT)

Product Name: Feature phone

Model No.: M32

FCC ID: 2AHS2-M32

FCC CFR Title 47 Part 2

Applicable standards: FCC CFR Title 47 Part 22 Subpart H

FCC CFR Title 47 Part 24 Subpart E

Date of sample receipt: 12 June, 2017

Date of Test: 12 June, to 11 July, 2017

Date of report issued: 11 July, 2017

Test Result: PASS*

* In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:



Bruce Zhang Laboratory Manager

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product and does not permit the use of the CCIS product certification mark. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

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2. Version

Version No.	Date	Description
00	11 July, 2017	Original

Tested by: (over (her Date: 11 July, 2017)

Test Engineer

Reviewed by: Date: 11 July, 2017

Project Engineer



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4. Test Summary

Test Item	Section in CFR 47	Result
RF Exposure (SAR)	Part 1.1307 Part 2.1093	Pass (Please refer to SAR Report)
RF Output Power	Part 2.1046 Part 22.913 (a)(2) Part 24.232 (c)	Pass
Peak-to-Average Power Ratio	Part 24.232 (d)	Pass
Modulation Characteristics	Part 2.1047	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049 Part 22.917(b) Part 24.238(b)	Pass
Spurious Emissions at Antenna Terminal	Part 2.1051 Part 22.917 (a) Part 24.238 (a)	Pass
Field Strength of Spurious Radiation	Part 2.1053 Part 22.917 (a) Part 24.238 (a)	Pass
Out of band emission, Band Edge	Part 22.917 (a) Part 24.238 (a)	Pass
Frequency stability vs. temperature	Part 22.355 Part 24.235 Part 2.1055(a)(1)(b)	Pass
Frequency stability vs. voltage	Part 22.355 Part 24.235 Part 2.1055(d)(2)	Pass

Pass: The EUT complies with the essential requirements in the standard.



5. General Information

5.1 Client Information

Applicant:	SHENZHEN COOTEL FONE TECHNOLOGY CO., LTD
Address of Applicant:	No.311, 3rd Floor, Langfeng Building, No.2, Kefa Road, Central Area of Science and Technology Park, Nanshan District, Shenzhen, China
Manufacturer:	SHENZHEN COOTEL FONE TECHNOLOGY CO., LTD
Address of Manufacturer:	No.311, 3rd Floor, Langfeng Building, No.2, Kefa Road, Central Area of Science and Technology Park, Nanshan District, Shenzhen, China

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5.2 General Description of E.U.T.

Product Name:	Feature phone
Model No.:	M32
Operation Frequency range:	GSM 850: 824.20MHz-848.80MHz PCS1900: 1850.20MHz-1909.80MHz
Modulation type:	GSM:GMSK, UMTS:QPSK
Antenna type:	Internal Antenna
Antenna gain:	GSM 850: 0.35dBi PCS 1900: 0.65dBi
Power supply:	Rechargeable Li-ion Battery DC3.7V-2550mAh
AC adapter:	Model: UOB2DOA50070 Input: AC100-240V 50/60Hz 120mA Output: DC 5.0V, 700mA





Operation Frequency List:

GSN	1 850	PCS1900		
Channel:	Frequency (MHz)	Channel:	Frequency (MHz)	
128	824.20	512	1850.20	
129	824.40	513	1850.40	
189	836.40	660	1879.80	
190	836.60	661	1880.00	
191	836.80	662	1880.20	
250	848.60	809	1909.60	
251	848.80	810	1909.80	

Regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

GSM850			PCS1900		
Channe	el	Frequency(MHz)	Channel		Frequency(MHz)
Lowest channel	128	824.20	Lowest channel	512	1850.20
Middle channel	190	836.60	Middle channel	661	1880.00
Highest channel	251	848.80	Highest channel	810	1909.80



5.3 Test modes

Voice mode Keep the EUT in voice mode on GSM 850 and PCS 1900 respectively.

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5.4 Measurement Uncertainty

Items	Expanded Uncertainty (Confidence of 95%)
Conducted Emission (9kHz ~ 30MHz)	2.14 dB (k=2)
Radiated Emission (9kHz ~ 30MHz)	4.24 dB (k=2)
Radiated Emission (30MHz ~ 1000MHz)	4.35 dB (k=2)
Radiated Emission (1GHz ~ 18GHz)	4.44 dB (k=2)
Radiated Emission (18GHz ~ 26.5GHz)	4.56 dB (k=2)

5.5 Related Submittal(s) / Grant (s)

This submittal(s) (test report) is filing to comply with Section Part 22 subpart H and Part 24 subpart E of the FCC CFR 47 Rules.

5.6 Test Methodology

Both conducted and radiated testing were performed according to the procedures document on TIA/EIA 603 and FCC CFR 47.1046, 2.1047, 2.1049, 2.1051, 2.1053, 2.1055 and 2.1057

5.7 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

• FCC - Registration No.: 817957

Shenzhen Zhongjian Nanfang Testing Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in out files. Registration 817957, February 27, 2012.

• IC - Registration No.: 10106A-1

The 3m Semi-anechoic chamber of Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 10106A-1.

• CNAS - Registration No.: CNAS L6048

Shenzhen Zhongjian Nanfang Testing Co., Ltd. is accredited to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L6048.

5.8 Laboratory Location

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Address: No. B-C, 1/F., Building 2, Laodong No.2 Industrial Park, Xixiang Road,

Bao'an District, Shenzhen, Guangdong, China

Website: http://www.ccis-cb.com

Tel: +86-755-23118282 Fax:+86-755-23116366 Email: info@ccis-cb.com

Shenzhen Zhongjian Nanfang Testing Co., Ltd. No. B-C, 1/F., Building 2, Laodong No.2 Industrial Park, Xixiang Road, Bao'an District, Shenzhen, Guangdong, China Telephone: +86 (0) 755 23118282 Fax: +86 (0) 755 23116366





5.9 Test Instruments list

Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
3m Semi- Anechoic Chamber	SAEMC	9(L)*6(W)* 6(H)	CCIS0001	08-23-2014	08-22-2017
BiConiLog Antenna	SCHWARZBECK MESS-ELEKTRONIK	VULB9163	CCIS0005	02-25-2017	02-24-2018
Double -ridged waveguide horn	SCHWARZBECK MESS-ELEKTRONIK	BBHA9120D	CCIS0006	02-25-2017	02-24-2018
EMI Test Software	AUDIX	E3	N/A	N/A	N/A
Amplifier (10kHz-1.3GHz)	HP	8447D	CCIS0003	02-25-2017	02-24-2018
Amplifier (1GHz-18GHz)	Compliance Direction Systems Inc.	PAP-1G18	CCIS0011	02-25-2017	02-24-2018
Pre-amplifier (18-26GHz)	Rohde & Schwarz	AFS33-18002 650-30-8P-44	GTS218	02-25-2017	02-24-2018
Horn Antenna	ETS-LINDGREN	3160	GTS217	02-25-2017	02-24-2018
Printer	HP	HP LaserJet P1007	N/A	N/A	N/A
Positioning Controller	UC	UC3000	CCIS0015	N/A	N/A
Spectrum analyzer 9k-30GHz	Rohde & Schwarz	FSP 30	CCIS0023	02-25-2017	02-24-2018
EMI Test Receiver	Rohde & Schwarz	ESPI	CCIS0022	02-25-2017	02-24-2018
EMI Test Receiver	Rohde & Schwarz	ESRP7	CCIS0167	02-25-2017	02-24-2018
Loop antenna	Laplace instrument	RF300	EMC0701	02-25-2017	02-24-2018
Universal radio communication tester	Rhode & Schwarz	CMU200	CCIS0069	02-25-2017	02-24-2018
Signal Analyzer	Rohde & Schwarz	FSIQ3	CCIS0088	02-25-2017	02-24-2018
DC Power Supply	Shenzhen XinNuoEr Technologies Co., Ltd.	WYK-10020K	CCIS0201	10-31-2016	10-30-2017
Temperature Humidity Chamber	Fo Shan Heng Pu Electronics Co., Ltd.	HPGDS-500	CCIS0240	11-18-2016	11-27-2017
Coaxial Cable	N/A	N/A	CCIS0018	02-25-2017	02-24-2018
Coaxial Cable	N/A	N/A	CCIS0020	02-25-2017	02-24-2018



6. System test configuration

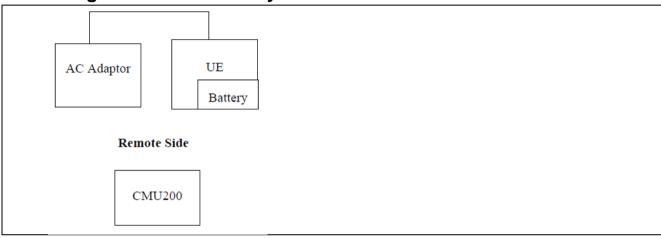
6.1 EUT Configuration

The EUT configuration for testing is installed on RF field strength measurement to meet the commission's requirement and operating in a manner which intends to maximize its emission characteristics in a continuous normal application.

6.2 EUT Exercise

The EUT (Transmitter) was operated in the engineering mode to fix the Tx frequency which was for the purpose of the measurements.

6.3 Configuration of Tested System



6.4 Description of Test Modes

The EUT has been tested under operating condition.

EUT staying in continuous transmitting mode. Channel Low, Mid and High for each type band with rated data rate were chosen for full testing.

The field strength of spurious radiation emission was measured as EUT stand-up position (H mode) and lie down position (E1, E2 mode) for three modes (GSM850, PCS1900.) with power adaptor, earphone and Data cable. The worst-case H mode for GSM850, PCS1900.





6.5 Conducted Output Power

T (D)					
Test Requirement:	FCC part 22.913(a)(2), FCC part 24.232(c)				
Test Method:	FCC part 2.1046				
Limit:	GSM 850: 7W				
	PCS 1900: 2W				
Test setup:	EUT ATT Communication Tester				
	Note: Measurement setup for testing on Antenna connector				
Test Procedure:	The transmitter output was connected to a calibrated attenuator, the other end of which was connected to the simulated station. Transmitter output power was read off in dBm.				
Test Instruments:	Refer to section 5.9 for details				
Test mode:	Refer to section 5.3 for details				
Test results:	Passed				



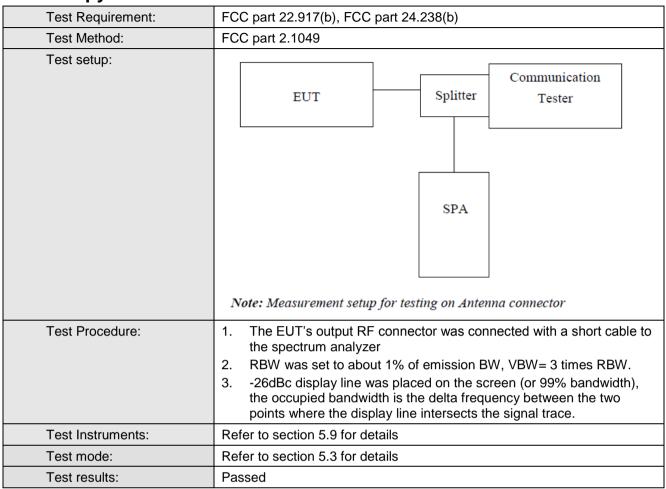
Measurement Data:

	Bur					
EUT Mode	128	190	251	Limit(dBm)		
	824.20MHz	836.60MHz	848.80MHz			
GSM 850	31.93	31.96	31.93	38.45		
	Bur					
EUT Mode	512	661	810	Limit(dBm)		
	1850.20MHz	1880.00MHz	1909.80MHz			
PCS 1900	30.88	30.85	30.93	33.00		





6.6 Occupy Bandwidth







Measurement Data:

modean official Batar				
EUT Mode	Channel	Frequency (MHz)	99% Occupy bandwidth (kHz)	-26dB bandwidth (kHz)
	128	824.2	238	306
GSM 850	190	836.6	246	302
	251	848.8	236	288
	512	1850.2	238	314
PCS 1900	661	1880.0	242	306
	810	1909.8	240	308



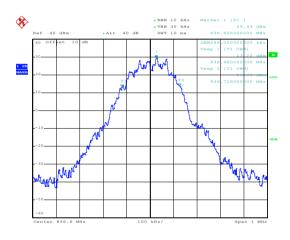
Test plot as follows:

99% Occupy bandwidth GSM850



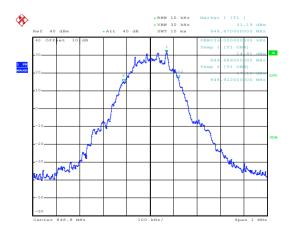
Date: 2.JUL.2017 23:29:19

Lowest channel



Date: 2.JUL.2017 23:29:11

Middle channel



Date: 2.JUL.2017 23:28:48

Highest channel



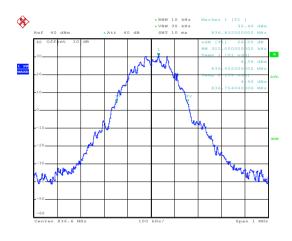
26dB Emission Bandwidth

GSM850



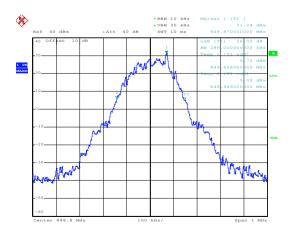
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Lowest channel



Date: 2.JUL.2017 23:29:04

Middle channel



Date: 2.JUL.2017 23:28:53

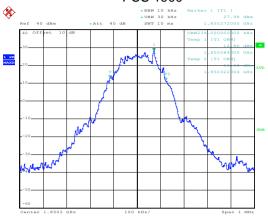
Highest channel

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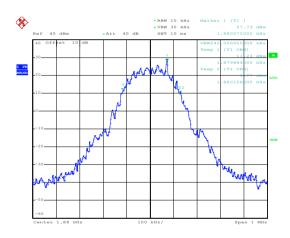
99% Occupy bandwidth

PCS 1900



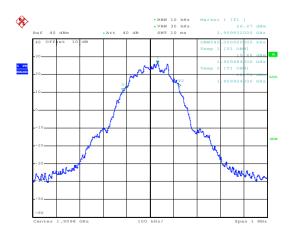
Date: 2.JUL.2017 23:25:22

Lowest channel



Date: 2.JUL.2017 23:25:46

Middle channel

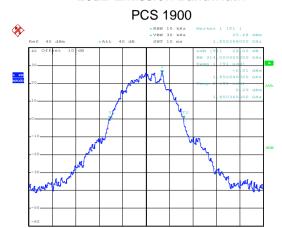


Date: 2.JUL.2017 23:26:04

Highest channel

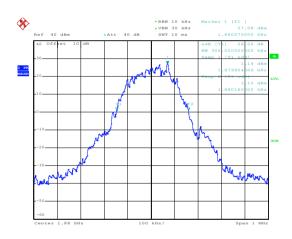


26dB Emission Bandwidth



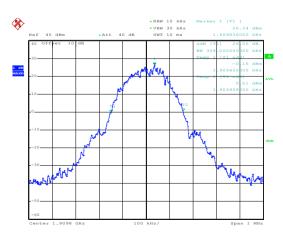
Date: 2.JUL.2017 23:25:28

Lowest channel



Date: 2.JUL.2017 23:25:40

Middle channel

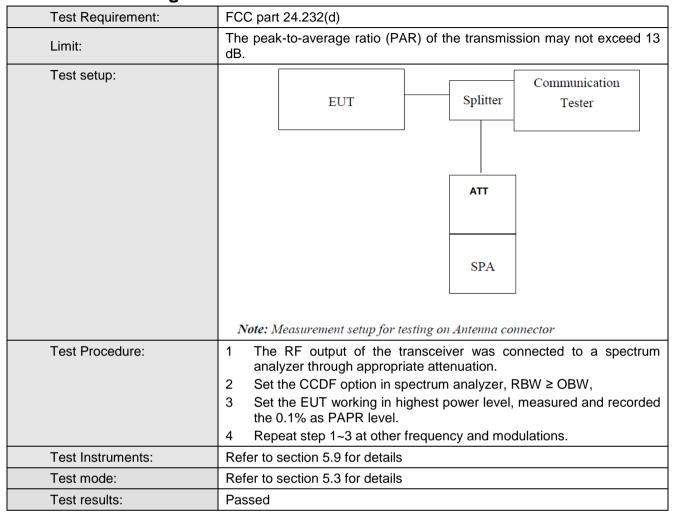


Date: 2.JUL.2017 23:26:11

Highest channel



6.7 Peak-to-Average Power Ratio



Measurement Data (worst case):

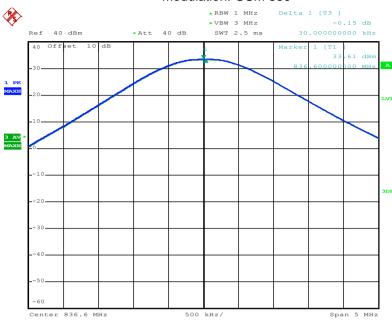
Modulation	Test channel	PAPR
GSM 850	190	0.15
PCS 1900	661	0.10



Test plots as below:

Middle channel

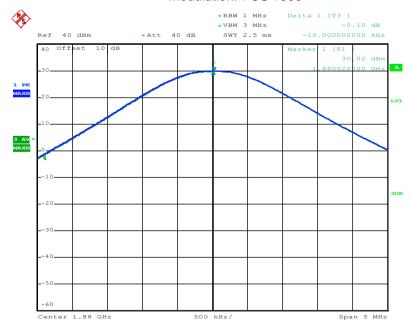




Date: 2.JUL.2017 23:31:01

Middle channel

Modulation: PCS 1900



Date: 2.JUL.2017 23:31:23



6.8 Modulation Characteristic

According to FCC \S 2.1047(d), Part 22H & 24E there is no specific requirement for digital modulation, therefore modulation characteristic is not presented.

6.9 Out of band emission at antenna terminals

Test Requirement:	FCC part 22.917(a), FCC part 24.238(a)				
Test Method:	FCC part 2.1051				
Limit:	-13dBm				
Test setup:	EUT Splitter Communication Tester				
	ATT				
	SPA				
Test Procedure:	Note: Measurement setup for testing on Antenna connector 5 The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation.				
	6 The resolution bandwidth of the spectrum analyzer was set at 100 kHz when below 1GHz, 1MHz when above 1 GHz; sufficient scans were taken to show the out of band Emissions if any up to 10th harmonic.				
	7 For the out of band: Set the RBW=100 kHz, VBW=300 kHz when below 1 GHz, RBW =1 MHz, VBW=3 MHz when above 1 GHz, Start=30MHz, Stop= 10th harmonic.				
	8 Band Edge Requirements: In the 1 MHz bands immediately outside and adjacent to the frequency block, a resolution bandwidth of at least 1 percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to measure the out of band Emissions.				
Test Instruments:	Refer to section 5.9 for details				
Test mode:	Refer to section 5.3 for details				
Test results:	Passed				



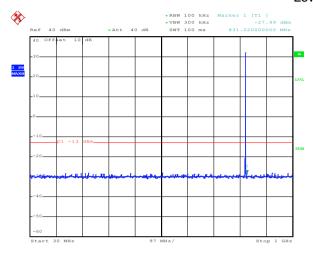


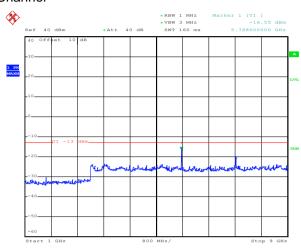
Test plots as follows:

Spurious emission:

GSM 850

Lowest Channel



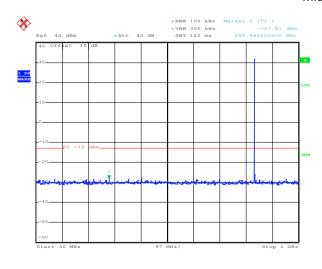


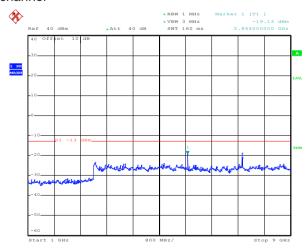
Date: 2.JUL.2017 22:46:06

30MHz~1GHz

1GHz~9GHz

Middle channel





Date: 2.JUL.2017 22:46:59

Date: 2.JUL.2017 23:02:57

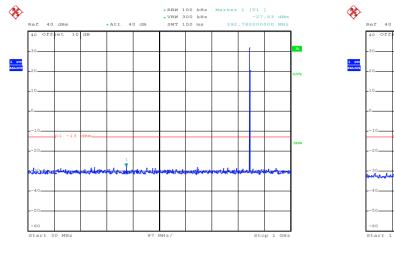
Date: 2.JUL.2017 23:08:20

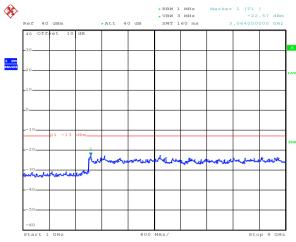
30MHz~1GHz

1GHz~9GHz



Highest Channel





Date: 2.JUL.2017 22:47:30

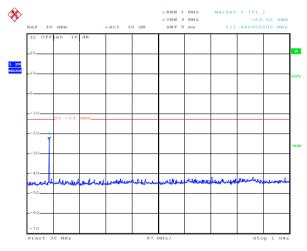
Date: 2.JUL.2017 23:13:58

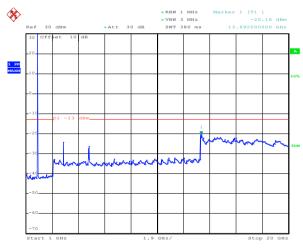
30MHz~1GHz

1GHz~9GHz

PCS 1900

Lowest Channel





Date: 2.JUL.2017 23:24:00

Date: 2.JUL.2017 23:20:28

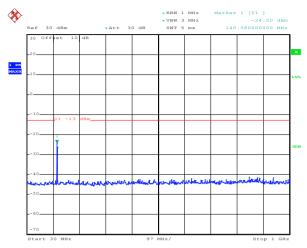
30MHz~1GHz

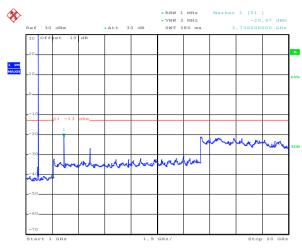
1GHz~20GHz





Middle Channel





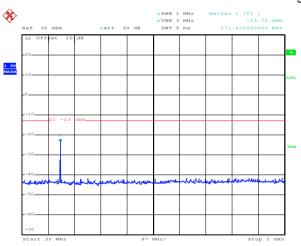
Date: 2.JUL.2017 23:23:43

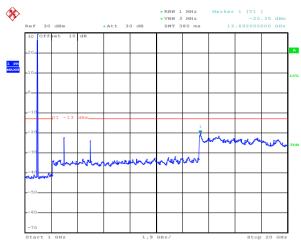
30MHz~1GHz

1GHz~20GHz

Highest Channel

Date: 2.JUL.2017 23:21:19





Date: 2.JUL.2017 23:23:19

Date: 2.JUL.2017 23:22:09

30MHz~1GHz

1GHz~20GHz

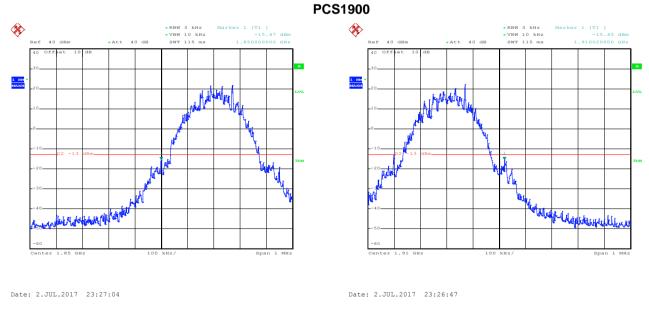


Band edge emission:



Lowest channel

Highest channel



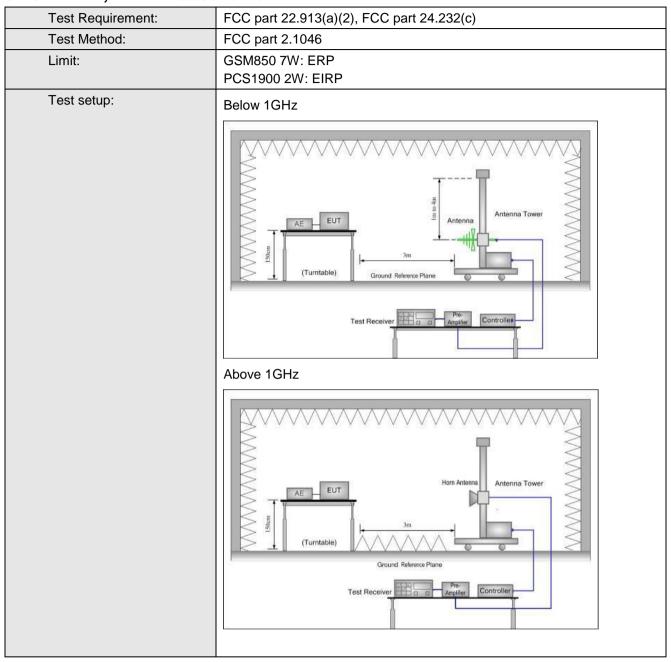
Lowest channel

Highest channel





6.10 ERP, EIRP Measurement







Test Procedure:	 The EUT was placed on an non-conductive turntable using a non- conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer. 		
	 During the measurement, the EUT was communication with the station. The highest emission was recorded with the rotation of the turntable and the lowering of the test antenna from 4m to 1m. The reading was recorded and the field strength (E in dBuV/m) was calculated. 		
	3. ERP in frequency band 824.2 –848.80.8MHz were measured using a substitution method. The EUT was replaced by dipole antenna connected, the S.G. output was recorded and ERP was calculated as follows:		
	ERP = S.G. output (dBm) + Antenna Gain (dBd) – Cable Loss (dB)		
	4. EIRP in frequency band 1850.2 –1909.8MHz were measured using a substitution method. The EUT was replaced by or horn antenna connected, the S.G. output was recorded and EIRP was calculated as follows:		
	EIRP = S.G. output (dBm) + Antenna Gain (dBi) – Cable Loss (dB)		
	5. The worse case was relating to the conducted output power.		
Test Instruments:	Refer to section 5.9 for details		
Test mode:	Refer to section 5.3 for details		
Test results:	Passed (All three channels were tested, and just the worst case data were shown in the report.)		





Measurement Data (worst case):

EUT mode	Channel	EUT Pol.	Antenna Pol.	ERP(dBm)	Limit (dBm)	Result
CCMOEO	254	ы	V	30.20	20.45	Door
GSM850	251	Н	Н	20.42	38.45	Pass

EUT mode	Channel	EUT Pol.	Antenna Pol.	EIRP(dBm)	Limit (dBm)	Result
PCS1900	810	Ц	V	22.00	22	Pass
FC31900	010	17	Н	15.69	33	F d S S



6.11 Field strength of spurious radiation measurement

	FCC nort 22 047(a) FCC nort 24 220(a)
Test Requirement: Test Method:	FCC part 2.1053
	FCC part 2.1053
Limit:	-13dBm
Test setup:	Below 1GHz Alterna Tower Test Receiver Angulier Controller
	Above 1GHz
	AE EUT Horn Anlenna Antenna Tower Ground Reference Plane Test Receiver Pre- Amplifer Controller
Test Procedure:	 The EUT was placed on an non-conductive turntable using a non-conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations. The frequency range up to tenth harmonic was investigated for each of three fundamental frequency (low, middle and high channels). Once spurious emission was identified, the power of the emission was determined using the substitution method. The spurious emissions attenuation was calculated as the difference between radiated power at the fundamental frequency and the spurious emissions frequency. ERP / EIRP = S.G. output (dBm) + Antenna Gain(dB/dBi) – Cable Loss (dB)
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details.
Test results:	Passed
10011004101	1





Measurement Data (worst case):

Test mode:	GSN	1850	Test channel:	Lowest	
Fraguency (MHz)	Spurious	Emission	Limit (dDm)	Result	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)		
1648.40	Vertical	-34.65			
2472.60	V	-35.79	12.00	Door	
3296.80	V	-48.51	-13.00	Pass	
4121.00	V	-37.10			
1648.40	Horizontal	-36.72			
2472.60	Н	-35.88	42.00	Door	
3296.80	Н	-58.58	-13.00	Pass	
4121.00	Н	-42.99			
Test mode:	GSN	1850	Test channel:	Middle	
Fragues and (MILE)	Spurious	Emission			
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
1673.20	Vertical	-33.11		Pass	
2509.80	V	-33.38			
3346.40	V	-46.14	-13.00		
4183.00	V	-38.59			
1673.20	Horizontal	-35.23			
2509.80	Н	-36.79		Pass	
3346.40	Н	-49.90	-13.00		
4183.00	Н	-43.20			
Test mode:	GSN	1850	Test channel:	Highest	
Fraguency (MHz)	Spurious	Emission	Limit (dDm)	Dooult	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
1697.60	Vertical	-30.72			
2546.40	V	-26.17	12.00	Pass	
3395.20	V	-46.68	-13.00	rass	
4244.00	V	-40.27]		
1697.60	Horizontal	-33.12			
2546.40	Н	-35.24	10.00	Dana	
3395.20	Н	-48.43	-13.00	Pass	

Remark:

1. The emission levels of below 1 GHz are very lower than the limit and not show in test report.





Test mode:	PCS1900		Test channel:	Lowest	
Frequency (MHz)	Spurious Emission		Limit (dBm)	Popult	
Frequency (MHZ)	Polarization	Level (dBm)	Lilliit (dbill)	Result	
3700.40	Vertical	-22.41	-13.00	Door	
5550.60	V	-21.21	-13.00	Pass	
3700.40	Horizontal	-22.40	-13.00	Pass	
5550.60	Н	-18.78	-13.00	Pass	
Test mode:	PCS	1900	Test channel:	Middle	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
Frequency (Wiriz)	Polarization	Level (dBm)	Lilliit (dBill)	Nesuit	
3760.00	Vertical	-25.15	-13.00	Pass	
5640.00	V	-20.29	-13.00	Pass	
3760.00	Horizontal	-25.15	-13.00	Pass	
5640.00	Н	-15.45	-13.00	Pa55	
Test mode:	PCS	1900	Test channel:	Highest	
Frequency (MHz)	Spurious	Emission	Limit (dPm)	Result	
Frequency (Wiriz)	Polarization	Level (dBm)	Limit (dBm)	Result	
3819.60	Vertical	-25.53	-13.00	Pass	
5729.40	V	-16.69	-13.00	F455	
3819.60	Horizontal	-28.44	12.00	Door	
5729.40	Н	-18.80	-13.00	Pass	

Remark:

^{1.} The emission levels of below 1 GHz are very lower than the limit and not show in test report.



6.12 Frequency stability V.S. Temperature measurement

Test Requirement:	FCC Part 22.355, FCC Part 24.235, FCC Part 2.1055(a)(1)(b)			
Test Method:	FCC Part 2.1055(a)(1)(b)			
Limit:	±2.5 ppm			
Test setup:	Spectrum analyzer EUT Att.			
Test procedure:	Variable Power Supply Note: Measurement setup for testing on Antenna connector 1. The equipment under test was connected to an external DC power			
·	 supply and input rated voltage. 2. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators. 3. The EUT was placed inside the temperature chamber. 4. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 25°C operating frequency as reference frequency. 5. Turn EUT off and set the chamber temperature to -30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency. 6. Repeat step measure with 10°C increased per stage until the highest temperature of +50°C reached 			
Test Instruments:	Refer to section 5.9 for details			
Test mode:	Refer to section 5.3 for details			
Test results:	Passed			
Remark:	All three channels of all modulations have been tested, but only the worst channel and the worst modulation show in this test item.			





Measurement Data (the worst channel):

	ne worst cnannel): ference Frequency: G	SM850 Middle	channel=190 chann	nel=836.6MHz	
Power supplied		Frequency error			
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
	-30	179	0.213961		
	-20	163	0.194836		
	-10	172	0.205594		
	0	154	0.184078		
3.70	10	139	0.166149	±2.5	Pass
	20	107	0.127899		
	30	129	0.154196		
	40	144	0.172125		
	50	163	0.194836		
Ret	erence Frequency: PC	CS1900 Middle	channel=661 chan	nel=1880MHz	
Power supplied	Tomporoture (°C)	Frequency error		Limit (nnm)	Dogult
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
	-30	183	0.097340		
	-20	162	0.086170		
	-10	178	0.094681		
3.70	0	102	0.054255		
	10	159	0.084574	±2.5	Pass
	20	142	0.075532		
	30	175	0.093085		
	40	165	0.087766	7	



6.13 Frequency stability V.S. Voltage measurement

Test Requirement:	FCC Part 22.355, FCC Part 24.235, FCC Part 2.1055(d)(2)			
Test Method:	FCC Part 2.1055(d)(1)(2)			
Limit:	±2.5ppm			
Test setup:	Temperature Chamber			
	Spectrum analyzer Att. Variable Power Supply Note: Measurement setup for testing on Antenna connector			
Test procedure:	 Set chamber temperature to 25°C. Use a variable DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency. Reduce the input voltage to specify extreme voltage variation (+/-15%) and endpoint, record the maximum frequency change. 			
Test Instruments:	Refer to section 5.9 for details			
Test mode:	Refer to section 5.3 for details, and all channels have been tested, only shows the worst channel data in this report.			
Test results:	Passed			





Measurement Data (the worst channel):

vieasureillelli Data (til	c worst charmery.						
Reference Frequency: GSM850 Middle channel=190 channel=836.6MHz							
Temperature (°C)	Power supplied	Frequ	iency error		- I		
remperature (e)	(Vdc)	Hz	ppm	Limit (ppm)	Result		
	4.20	83	0.099211				
25	3.70	92	0.109969	±2.5	Pass		
	3.50	96	0.114750				
Refe	erence Frequency: P0	CS1900 Middle	channel=661 chann	el=1880MHz			
Tomporature (°C)	Power supplied Frequency error				Dooult		
Temperature (℃)	(Vdc)	Hz	ppm	Limit (ppm)	Result		
	4.20	91	0.048404				
25	3.70	75	0.039894	±2.5	Pass		
	3.50	82	0.043617				